- AEP -
Automatic Exchange of Embedded Software Parameters

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Agenda

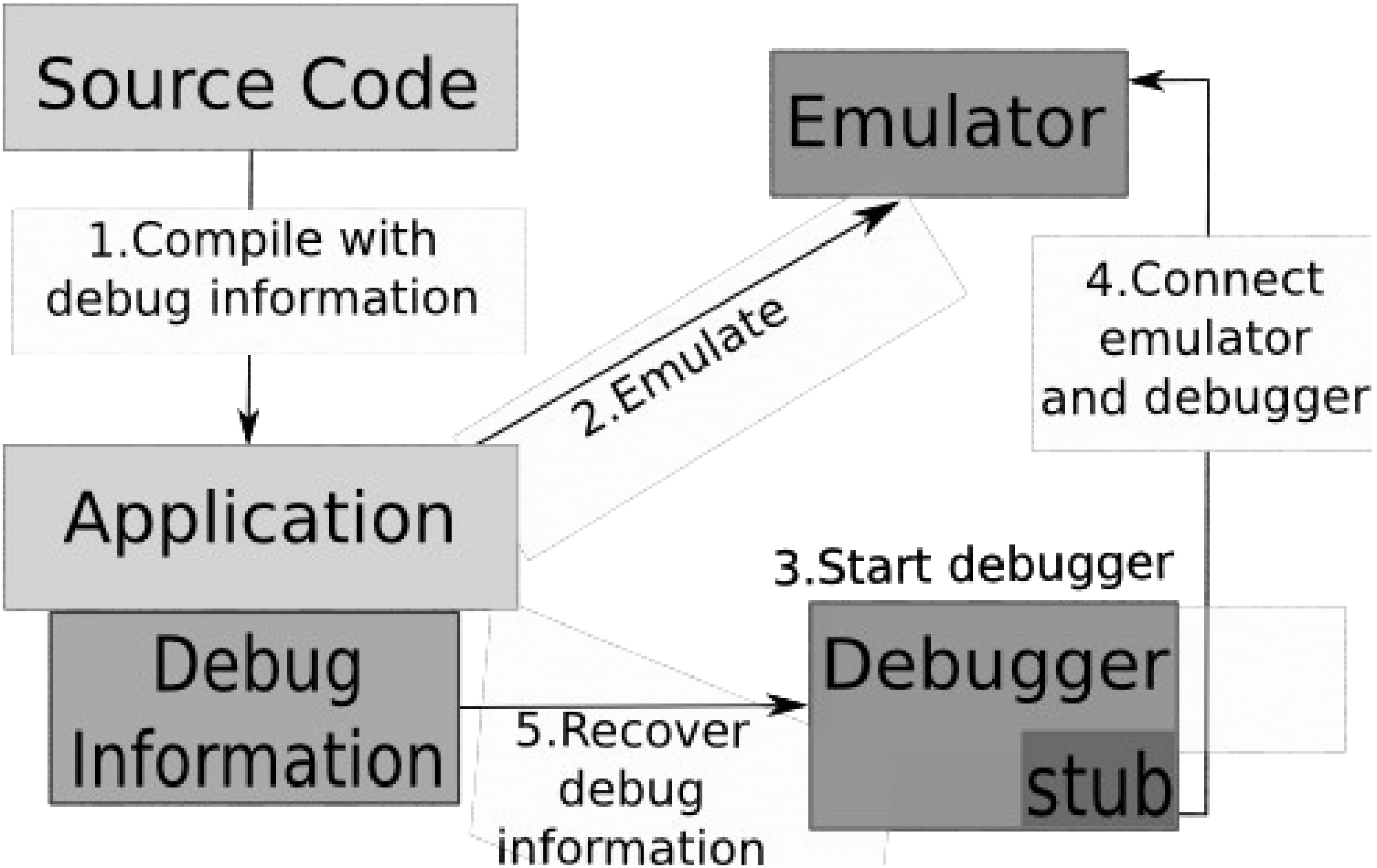
- Introduction
  - The problem of testing
- Embedded systems environment
  - Support for testing and debugging
- Automatic exchange of embedded system software parameters
  - General algorithm and implementation details
- Results
  - Classification of configurations, execution time and size of additional information
- Conclusion and Future work

Introduction

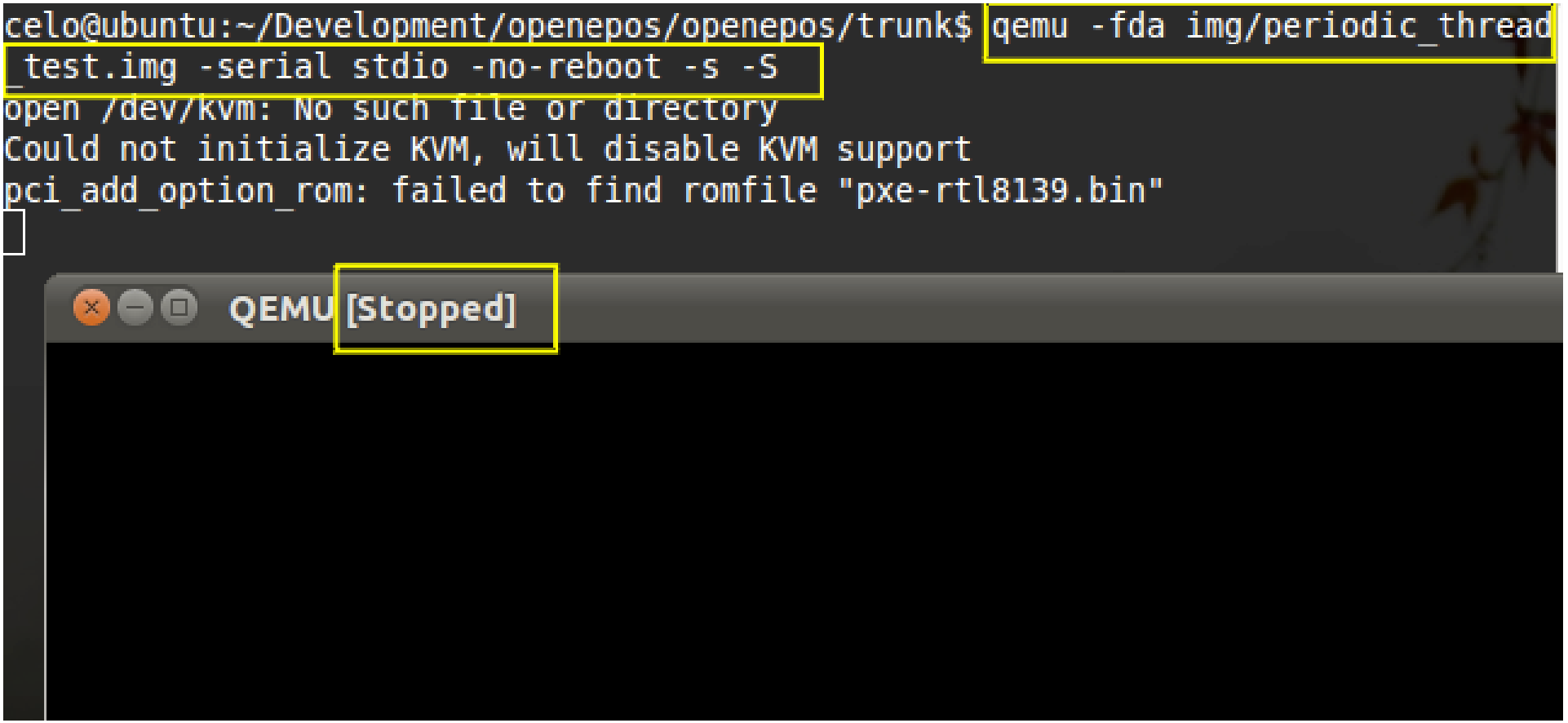
- Embedded system
  - Combination of software and hardware designed to perform a specific task
  - Popular and intrinsic to humans daily life

- Software testing
  - Analyse and detect the differences between existing and required conditions
  - Non-trivial and time-consuming
  - Embedded software testing should also consider software/hardware integration
  - Once a test fail, debugging can locate/identify bugs and then correct the software.

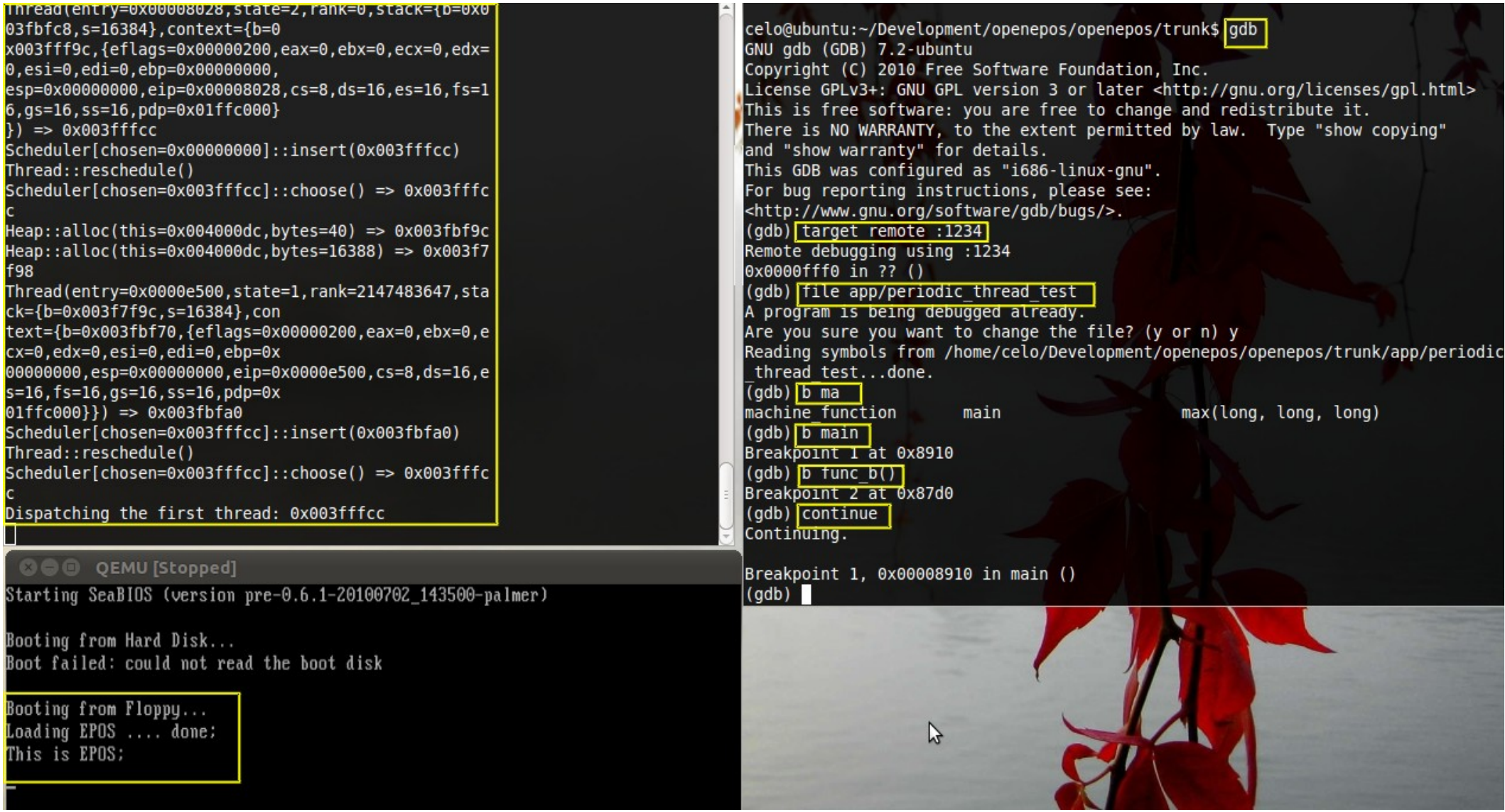
Embedded systems debugging environment



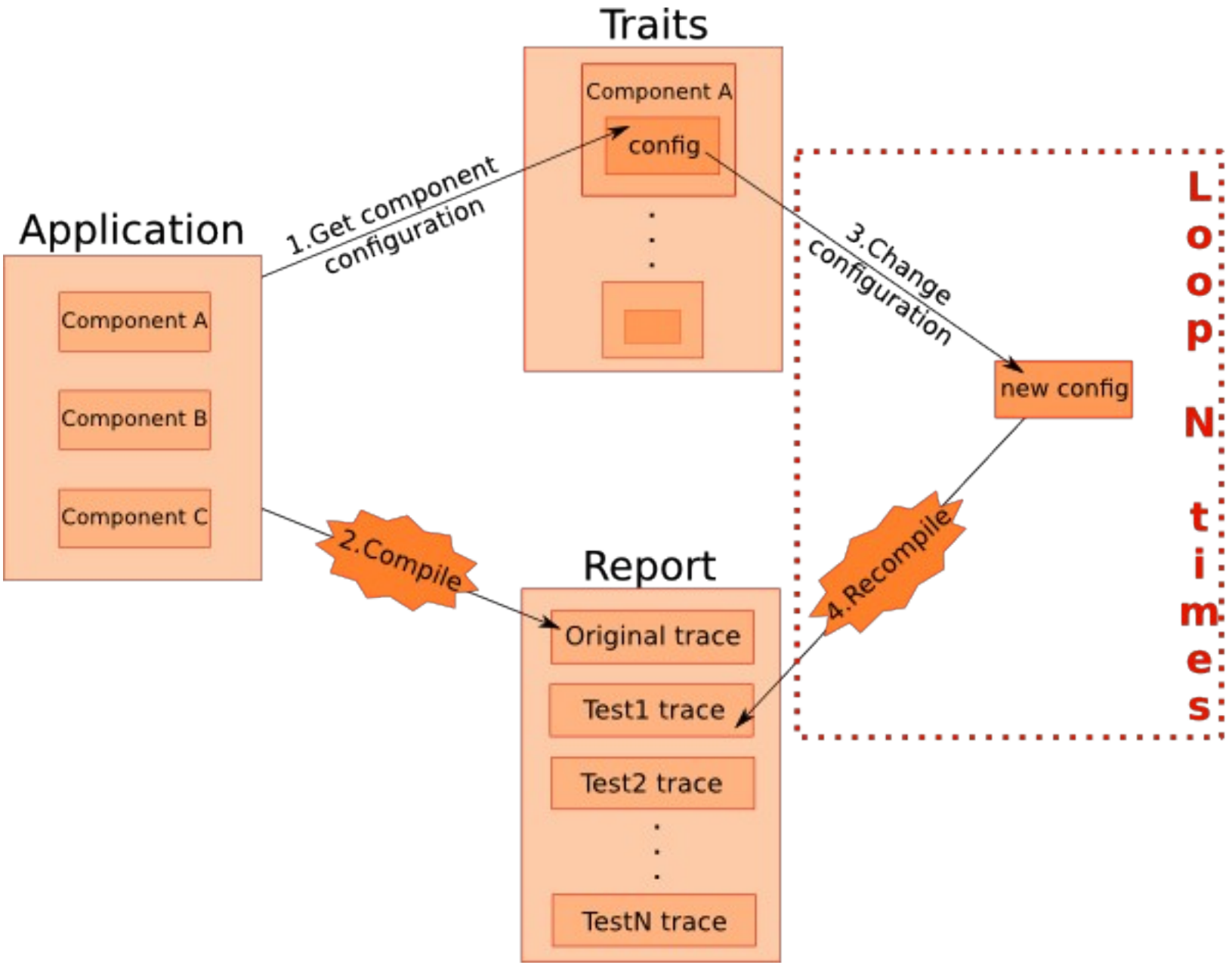
Embedded systems debugging environment



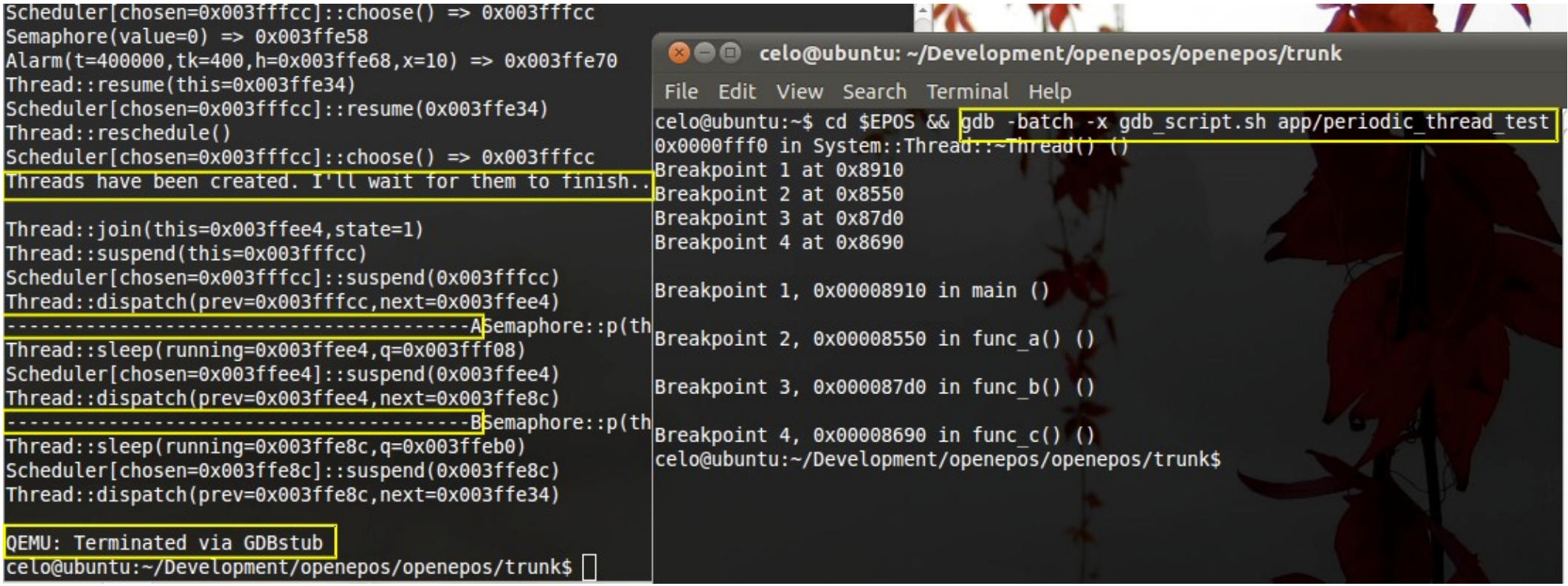
Embedded systems debugging environment



Automatic exchange of software parameters



Automatic exchange of software parameters



AEP - Automatic exchange of embedded system software parameters

- Requirements
  - Application-Oriented System Design
  - Feature Based Model
  - Parametric Model
- Granularity of configuration
  - Random (worst-case)
  - Partially random
  - Determined
- Definition of exchange success
  - No compilation errors
  - Is there a register on the exchange on the report
  - No difference between traces logs

AEP - Automatic exchange of embedded system software parameters

```
.*.*.*.*.* Test Report .*.*.*.*.*
Application= dmec_app

Original line = #define NUM_WORKERS 6
VALUES = 67,53,87,3,64,35,16,75,82,47,
79,70,81,12,46,84,68,18,76,26,
86,66,90,89,67,9,87,19,81,24,
31,2,12,24,58,33,15,3,55,4,
0,17,67,96,0,34,5,70,34,35,
27,41,40,88,94,45,96,7,55,72,
98,42,91,97,4,70,28,35,69,29,
34,19,28,72,15,96,29,39,87,72,
27,15,23,10,92,72,8,12,17,40,
62,42,17,90,45,83,35,81,10,7
```

AEP - Automatic exchange of embedded system software parameters

```
<test>
   <application name="philosopher_dinner_app"></application>
      <configuration>
         <trait>
            <id>ARCH</id>
            <value>IA32</value>
            <value>AVR8</value>
         </trait>

         <debug>
            <path>"/home/breakpoint_philosopher.txt"<path>
         </debug>
   </configuration>
<test>
```

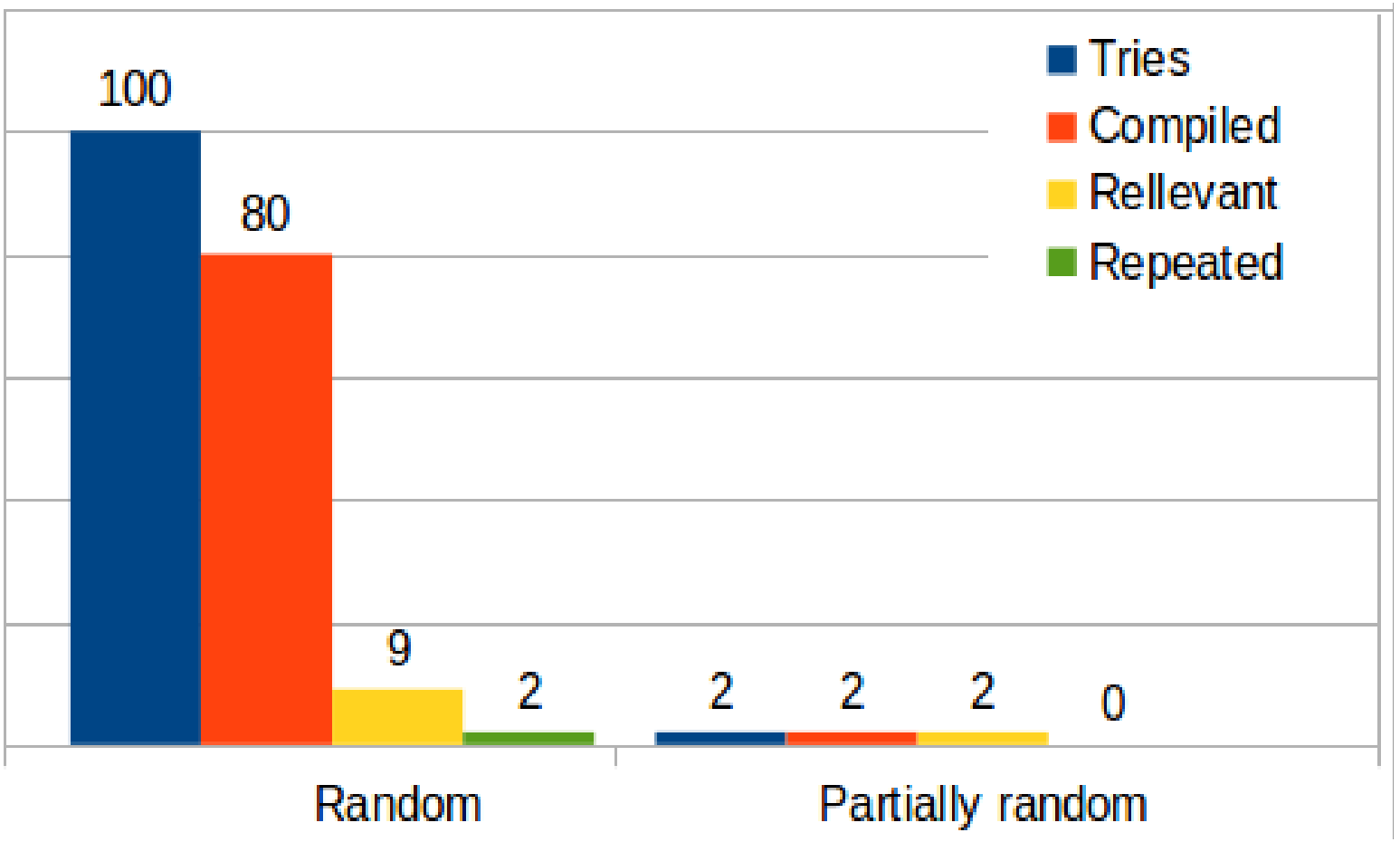
AEP - Automatic exchange of embedded system software parameters

- XML configuration file:
  - Application
    - Name
  - Exchange of parameters
    - Traits
    - Values
    - Interval
    - Number of tries
  - Debugging
    - File with debugging commands
    - Compare traces

Results

Philosopher's Dinner

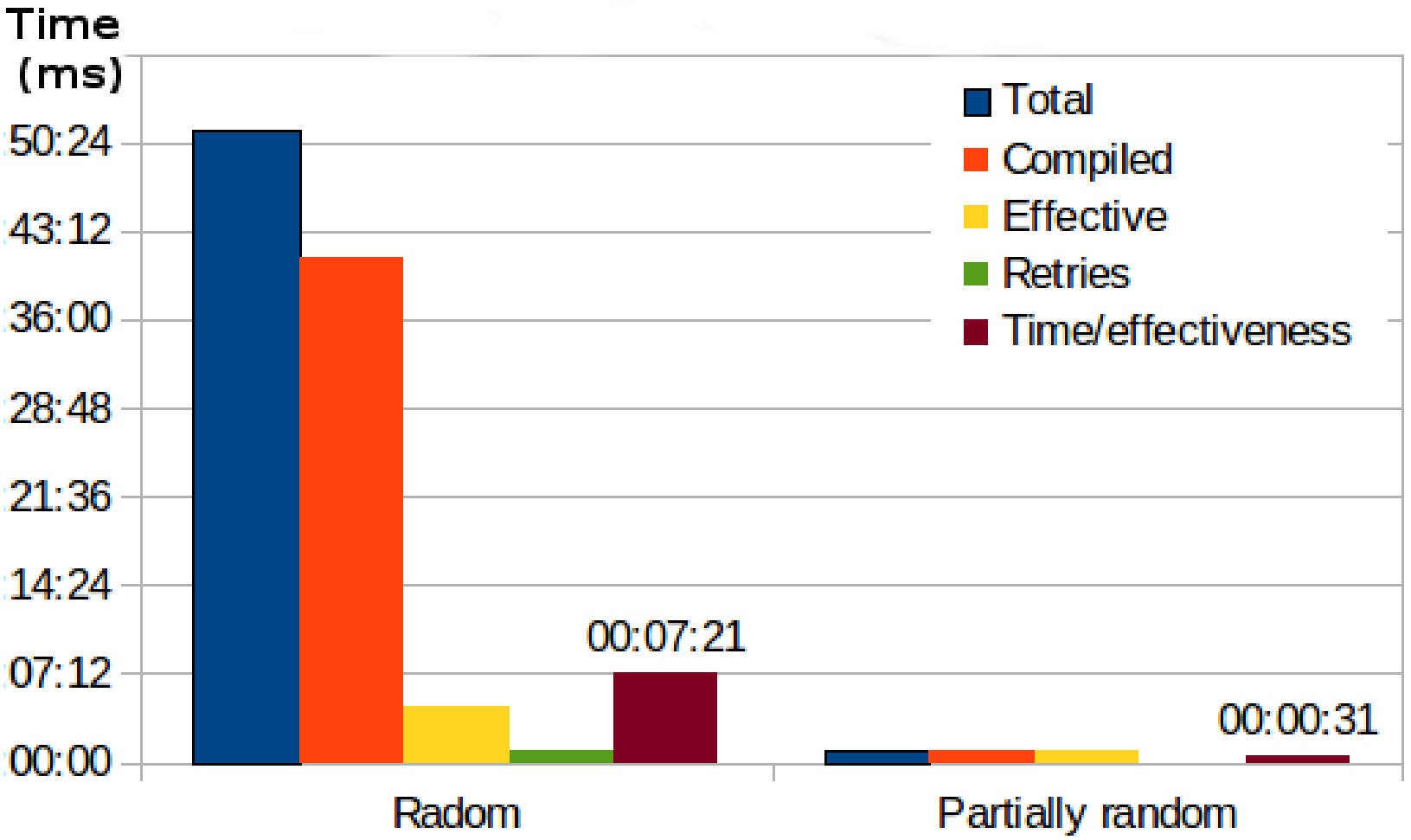
Classification generated configurations



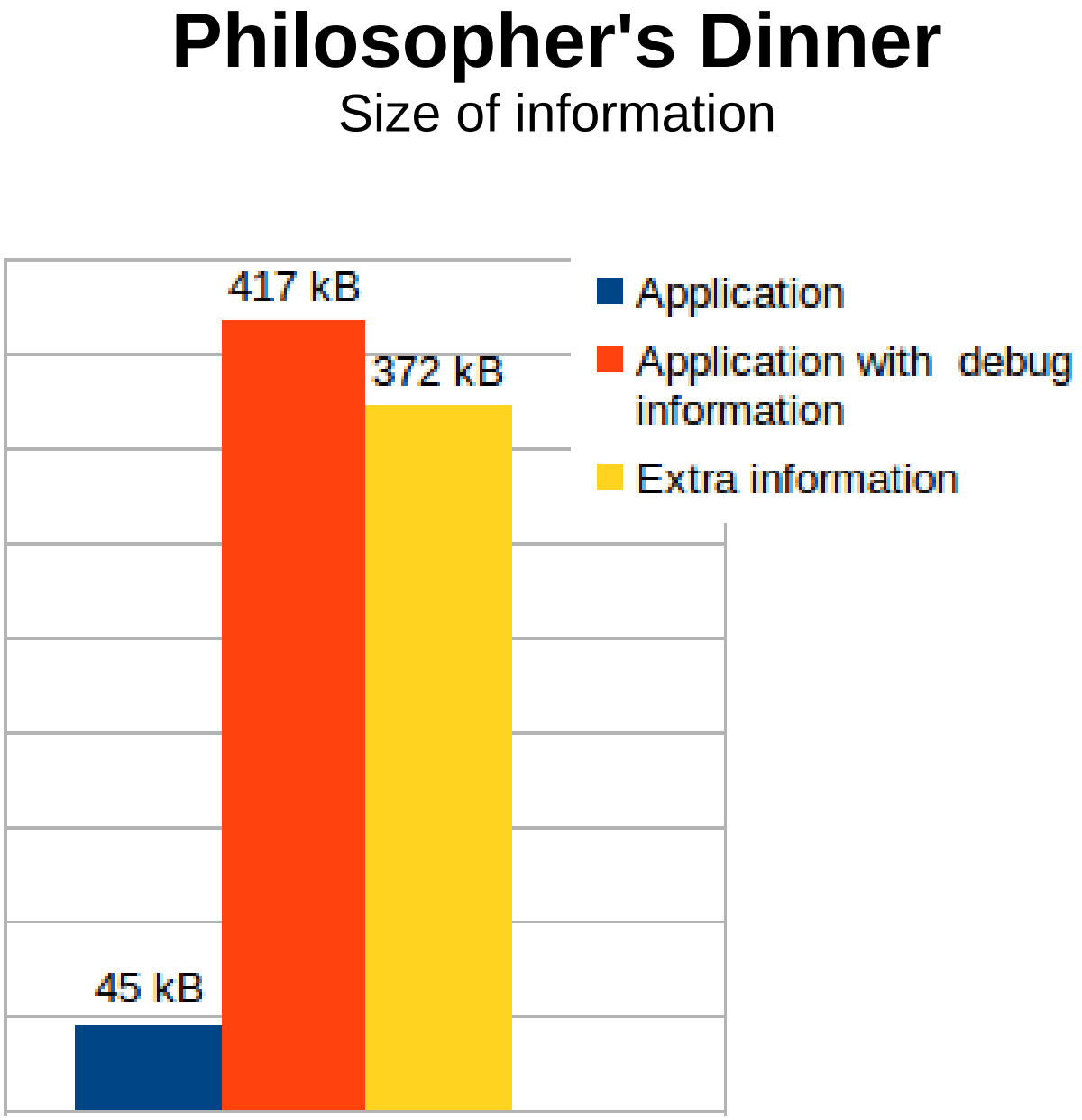
Results

Philosopher's Dinner

Classification of execution time



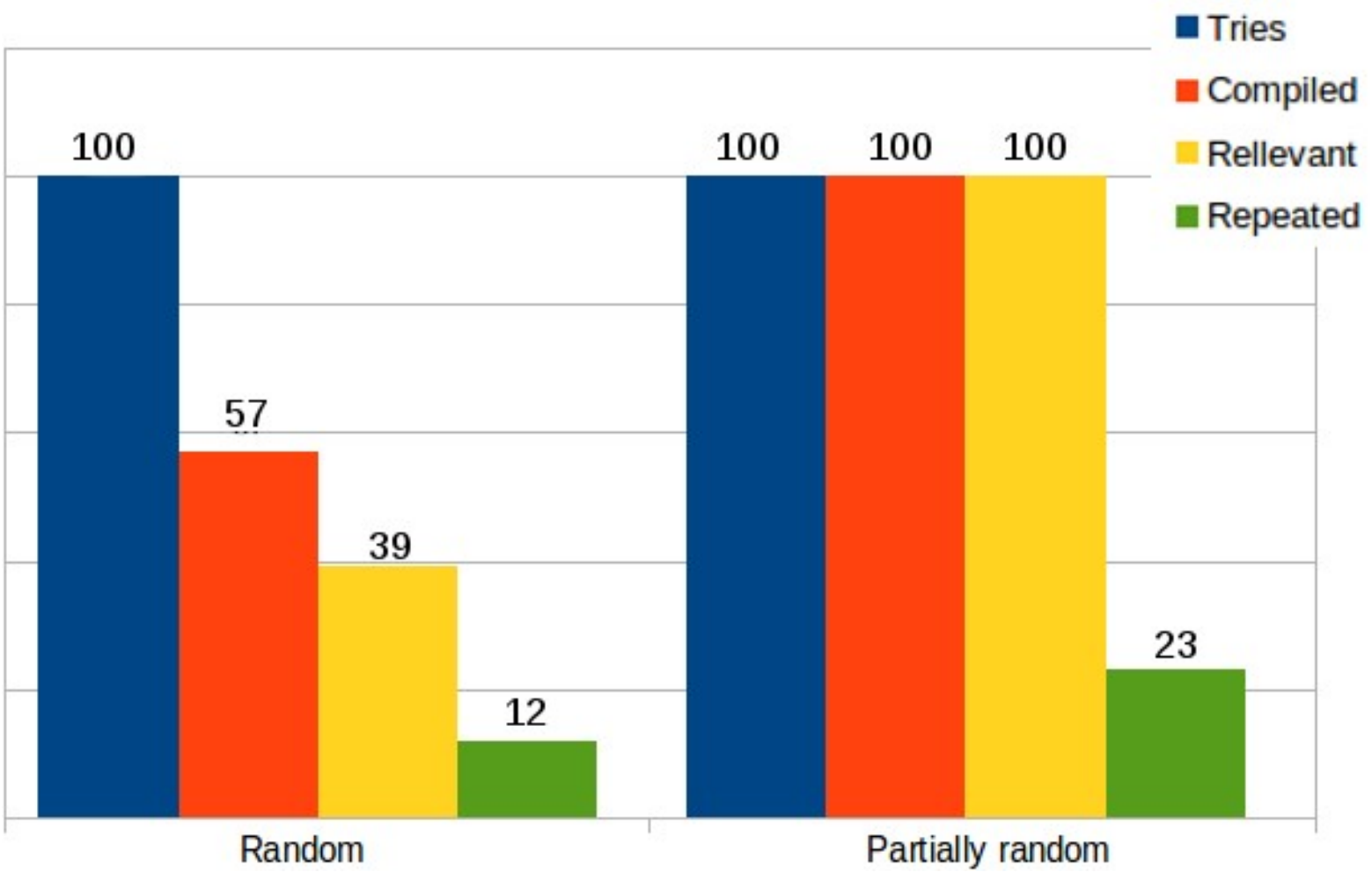
Results


Philosopher's Dinner
Size of information
417 kB
372 kB
45 kB
Application
Application with debug information
Extra information

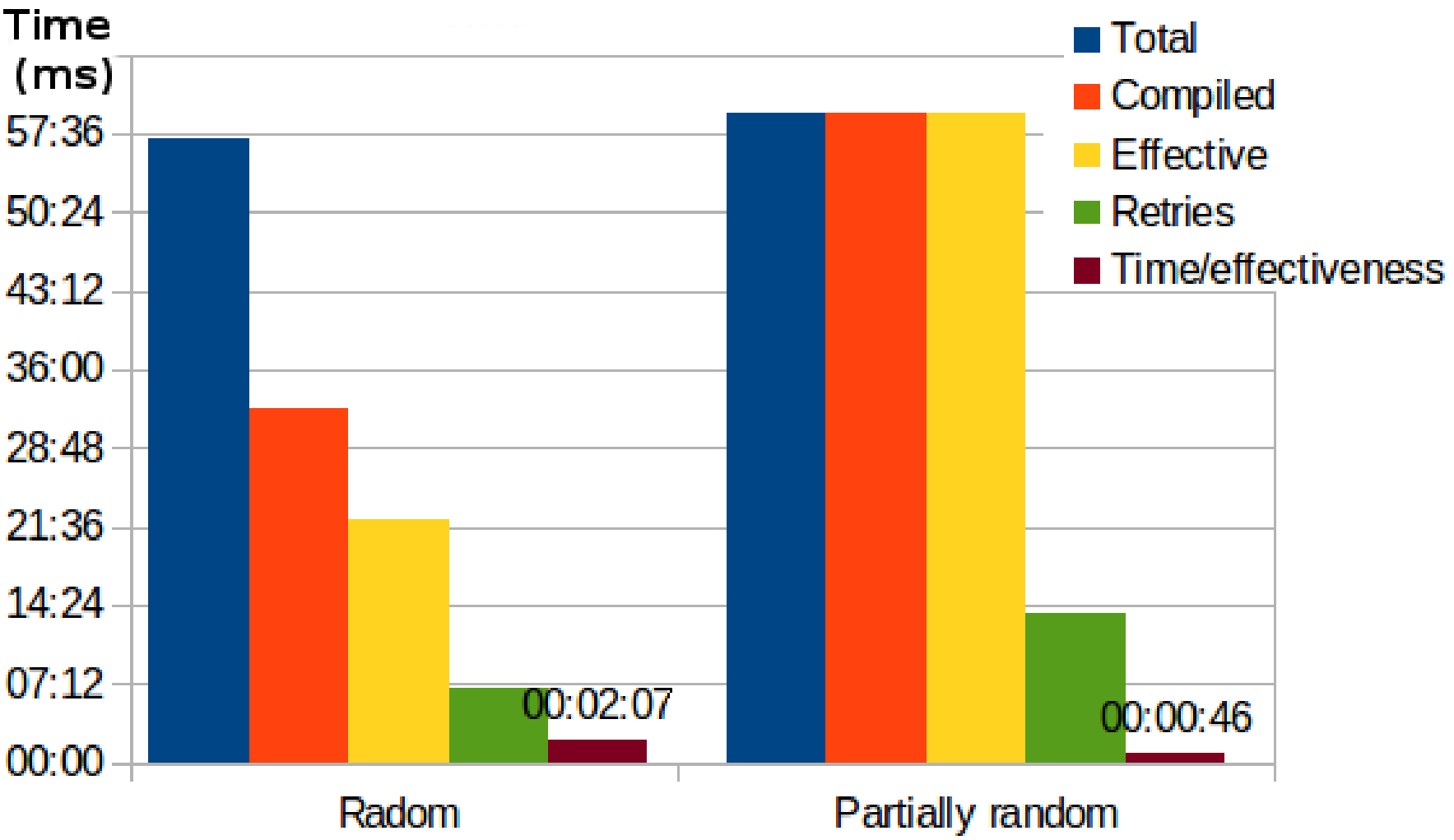
Results

DMEC

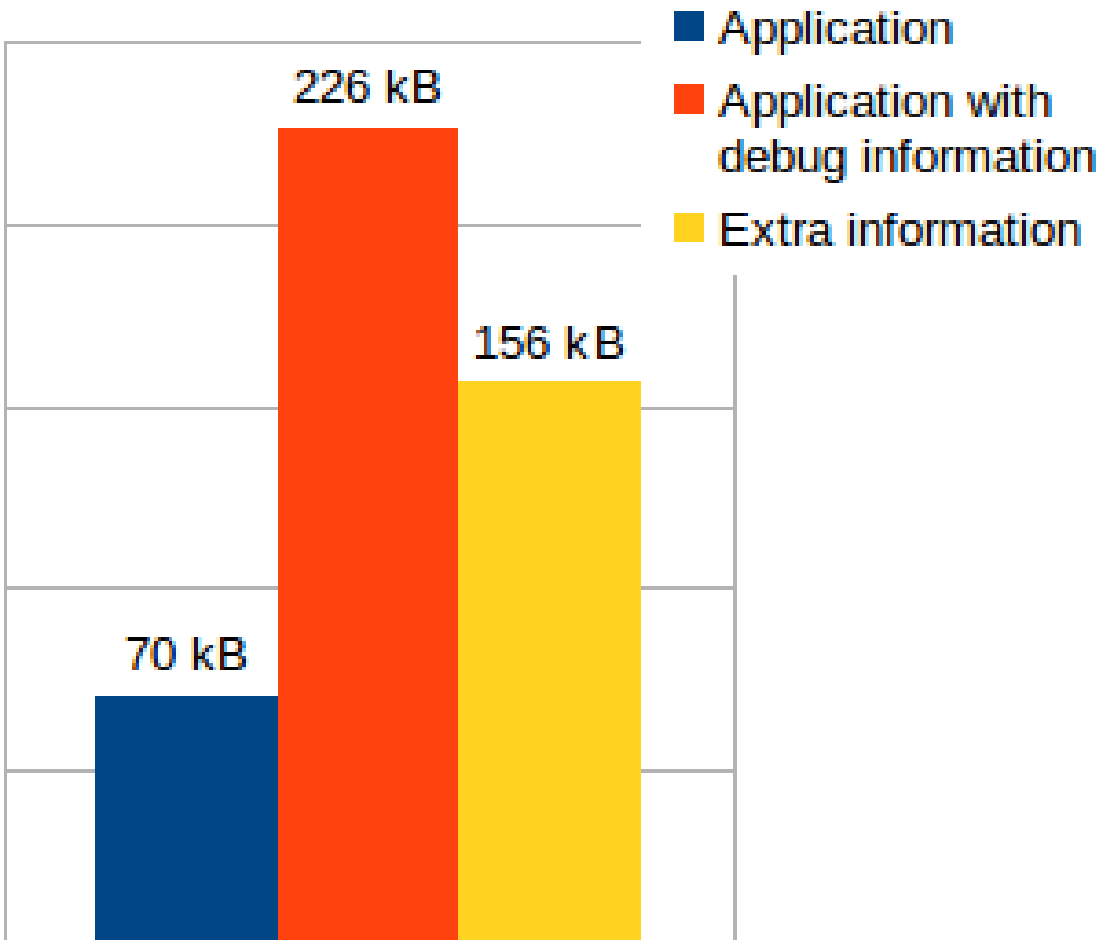
Classification generated configurations



Results


DMEC
Classification of execution time
Time (ms)
57:36
50:24
43:12
36:00
28:48
21:36
14:24
07:12
00:00
Total
Compiled
Effective
Retries
Time/effectiveness
00:02:07
00:00:46
Radom
Partially random

Results


DMEC
Size of information
Application
Application with debug information
Extra information
226 kB
156 kB
70 kB

Conclusion and Future work

- This work show that it is possible to create an stable development environment for embedded systems

- The activity of verify this become simpler, since the testing and debugging can share the same environment
  - If necessary a manual debugging, the AEP report can provide useful information

- As future work, there are some improvements, such as:
  - Extract input data directly from application
  - Support new types of testing
  - Deepen the level of information in the report, also returning an analysis of data collected from the application